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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : TBD

Applicant : Nobuyuki Uemura

Filed : Herewith

Title : "HIGH RATE LINE-BY-LINE CALCULATION METHOD

AND PROGRAM BY FORKED LINE TYPE RESOLUTION"

Confirmation No. : TBD TC/A.U. : TBD Examiner : TBD

International App. No. : PCT/JP2004/012301 International Flg. Date : August 26, 2004

Customer No. : 116
Docket No. : 40148

## INFORMATION DISCLOSURE STATEMENT

Mail Stop PCT Commissioner for Patents P.O. Box 1450 Alexandria, Va. 22313-1450

Sir/Madam:

In accordance with Rule 56, applicant is aware of the publications listed in the International Search Report (ISR, copy enclosed) and in the enclosed copy of Patent Office Form 1449. Copies of the publications cited in the International Search Report are not enclosed as they were previously forwarded by the International Bureau.

If there are any fees required by this communication, please charge such fees to our Deposit Account No. 16-0820. Order No. 40148.

Respectfully submitted,

PEARNE & GORDON LLP

By: Michael W. Garvey, Reg. No. 35878

1801 East 9th Street Suite 1200 Cleveland, Ohio 44114-3108 (216) 579-1700

March 29, 2006

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U.S. DEPARTMENT OF COMMERCE Form PTO-1449 ATTY. DOCKET NO. -SERIAL NO. PATENT AND TRADEMARK OFFICE 40148 TBD APPLICANT: Nobuvuki Uemura INFORMATION DISCLOSURE CITATION BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY) FILING DATE: GROUP ART UNIT Herewith TRD U.S. PATENT DOCUMENTS Examiner Document No. Filing Date Date Name Class Subclass Initial Appropriate Α В C D Е F G н I J FOREIGN PATENT DOCUMENTS Document No. Date Country Class Subclass Translation 2001-300733 05/2001 JAPAN Cited on ISR N P OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) de Mul et al., "The MCGA (Multiple Cubic Gradient Approximation) Method for the Analysis of Raman Spectra", Journal of Raman Spectroscopy, Vol. 21, 1999, pages 725-736 (Cited on Uemura, "Windows Based Line-by-Line Radiative Computation Using Mathead", Fujitsu FIP Corporation, Tokyo, Japan, http://www.imk.fzk.de/asf/ame/assfts/P I 8 Uemura N.pdf, 2004, pages (Cited on ISR) Examiner: /Bryan Bui/ Date Considered 08/09/2011 \*Examiner: Initial if reference considered, regardless of whether citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.